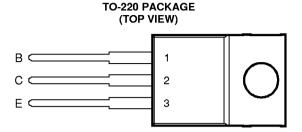
- Designed Specifically for High Frequency Electronic Ballasts
- Integrated Fast t<sub>rr</sub> Anti-Parallel Diode, Enhancing Reliability
- Diode t<sub>rr</sub> Typically 1 μs
- Tightly Controlled Transistor Storage Times
- Voltage Matched Integrated Transistor and Diode
- Characteristics Optimised for Cool Running
- Diode-Transistor Charge Coupling Minimised to Enhance Frequency Stability

#### description

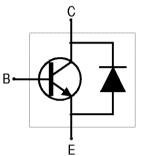
The new BULDxx range of transistors have been designed specifically for use in High Frequency Electronic Ballasts (HFEB's). This range of switching transistors has tightly controlled storage times and an integrated fast t<sub>rr</sub> antiparallel diode. The revolutionary design ensures that the diode has both fast forward and reverse recovery times, achieving the same performance as a discrete anti-parallel diode plus transistor. The integrated diode has minimal charge coupling with the transistor, increasing frequency stability, especially in lower power circuits where the circulating currents are low. By design, this new device offers a voltage matched integrated transistor and anti-parallel diode.



Pin 2 is in electrical contact with the mounting base

MDTRACA

#### device symbol



# absolute maximum ratings at 25°C case temperature (unless otherwise noted)

RATING	SYMBOL	VALUE	UNIT
Collector-emitter voltage (V <sub>BE</sub> = 0)	V <sub>CES</sub>	600	٧
Collector-base voltage (I <sub>E</sub> = 0)	V <sub>CBO</sub>	600	V
Collector-emitter voltage (I <sub>B</sub> = 0)	V <sub>CEO</sub>	400	V
Emitter-base voltage	V <sub>EBO</sub>	9	V
Continuous collector current	Ic	8	Α
Peak collector current (see Note 1)	I <sub>CM</sub>	12	Α
Continuous base current	I <sub>B</sub>	4	Α
Peak base current (see Note 1)	I <sub>BM</sub>	6	Α
Continuous device dissipation at (or below) 25°C case temperature	P <sub>tot</sub>	85	W
Maximum average continuous diode forward current at (or below) 25°C case temperature	I <sub>E(av)</sub>	0.5	Α
Operating junction temperature range	T <sub>j</sub>	-65 to +150	°C
Storage temperature range	T <sub>stg</sub>	-65 to +150	°C

NOTE 1: This value applies for  $t_0 = 10$  ms, duty cycle  $\le 2\%$ .



# BULD125KC NPN SILICON TRANSISTOR WITH INTEGRATED DIODE

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# electrical characteristics at 25°C case temperature

	PARAMETER		TEST CONDITIO	NS	MIN	TYP	MAX	UNIT
V <sub>CEO(sus)</sub>	Collector-emitter sustaining voltage	I <sub>C</sub> = 0.1 A	L = 25 mH		400			٧
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> = 600 V	V <sub>BE</sub> = 0				10	μA
I <sub>EBO</sub>	Emitter cut-off current	V <sub>EB</sub> = 9 V	I <sub>C</sub> = 0				1	mA
V <sub>BE(sat)</sub>	Base-emitter saturation voltage	I <sub>B</sub> = 0.3 A	I <sub>C</sub> = 1.5 A	(see Notes 2 and 3)		0.9	1.1	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	I <sub>B</sub> = 0.3 A I <sub>B</sub> = 0.6 A	$I_{\rm C} = 1.5  {\rm A}$ $I_{\rm C} = 3  {\rm A}$	(see Notes 2 and 3)		0.2 0.4	0.5 1	V
h <sub>FE</sub>	Forward current transfer ratio	$V_{CE} = 10 V$ $V_{CE} = 1 V$ $V_{CE} = 5 V$	$I_{C} = 0.01 \text{ A}$ $I_{C} = 1.5 \text{ A}$ $I_{C} = 3 \text{ A}$	(see Notes 2 and 3)	10 10 10	18 15 16	20 20	
V <sub>EC</sub>	Anti-parallel diode forward voltage	I <sub>E</sub> = 1 A		(see Notes 2 and 3)		1.1	1.5	V

NOTES: 2. These parameters must be measured using pulse techniques,  $t_0 = 300 \,\mu s$ , duty cycle  $\leq 2\%$ .

#### thermal characteristics

	PARAMETER		TYP	MAX	UNIT
$R_{\theta J A}$	A Junction to free air thermal resistance			62.5	°C/W
$R_{\theta J}$	C Junction to case thermal resistance			1.47	°C/W

# switching characteristics at 25°C case temperature

		PARAMETER	TEST CONDITIONS N		MIN	TYP	MAX	UNIT
ĺ		Anti-parallel diode	Measured by holding transistor	see Note 4)		4		
	۲rr	reverse recovery time	in an off condition, $V_{EB} = -3 \text{ V}$ .	(see Note 4)		'		μs

NOTE 4: Tested in a typical High Frequency Electronic Ballast.

#### inductive-load switching characteristics at 25°C case temperature

PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
t <sub>sv</sub> Storage time	l <sub>C</sub> = 1.5 A L = 1 mH	$I_{B(on)} = 0.3 A$ $I_{B(off)} = 0.3 A$	$V_{CC} = 40 \text{ V}$ $V_{CLAMP} = 300 \text{ V}$		4	5	μs

# resistive-load switching characteristics at 25°C case temperature

Ī	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	t <sub>fi</sub> Current fall time	$I_{C} = 1.5 \text{ A}$ $I_{B(on)} = 0.3 \text{ A}$ $I_{CC} = 300 \text{ V}$ $I_{B(off)} = 0.3 \text{ A}$		150	250	ns

# PRODUCT INFORMATION

<sup>3.</sup> These parameters must be measured using voltage-sensing contacts, separate from the current carrying contacts, and located within 3.2 mm from the device body.

#### TYPICAL CHARACTERISTICS

# COLLECTOR CURRENT T<sub>C</sub> = 25°C V<sub>CE</sub> = 1 V V<sub>CE</sub> = 10 V OOLLECTOR CURRENT LD125CHF LD125CHF

Figure 1.

ANTI-PARALLEL DIODE INSTANTANEOUS FORWARD CURRENT VS
INSTANTANEOUS FORWARD VOLTAGE

LD12SCVF

TC = 25°C

10

0.01

0.05

1.0

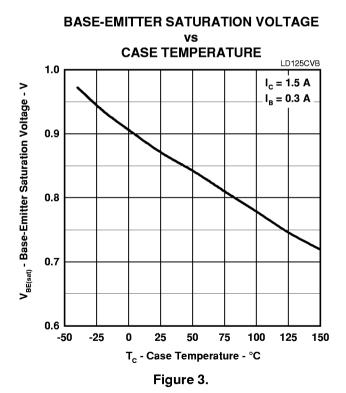
1.5

2.0

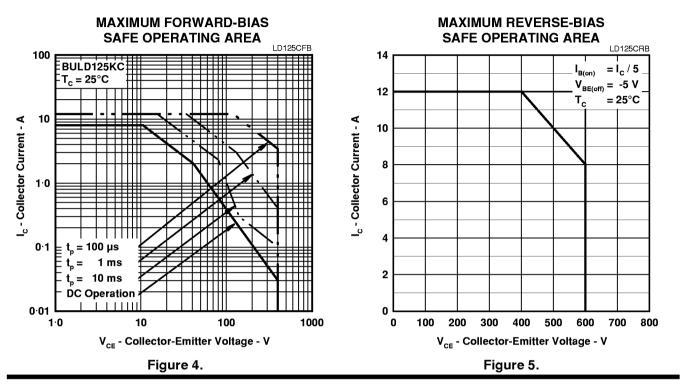
2.5

V<sub>EC</sub> - Instantaneous Forward Voltage - V

Figure 2.

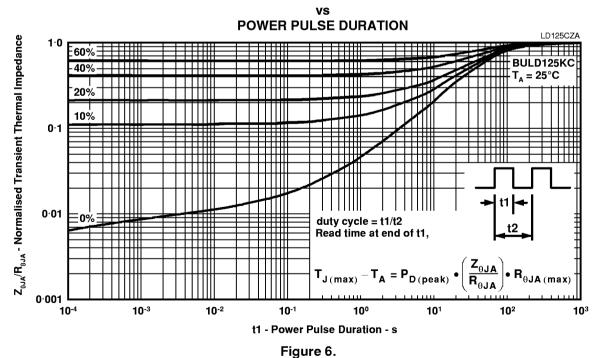


#### **MAXIMUM SAFE OPERATING REGIONS**



#### THERMAL INFORMATION

#### THERMAL RESPONSE JUNCTION TO AMBIENT



PRODUCT INFORMATION

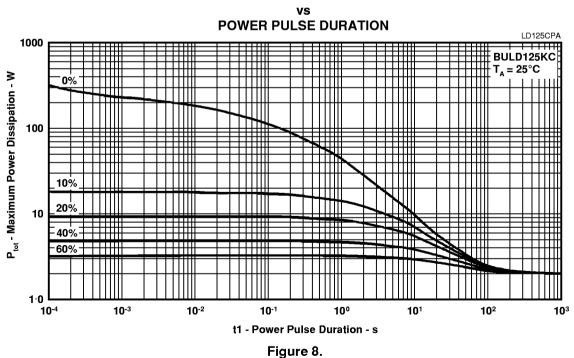
#### THERMAL INFORMATION

## THERMAL RESPONSE JUNCTION TO CASE

#### **POWER PULSE DURATION** LD125CZC $\mathsf{Z}_{\mathsf{9JC}}/\mathsf{R}_{\mathsf{9JC}}$ - Normalised Transient Thermal Impedance 1.0 BULD125KC 60% $T_c = 25^{\circ}C$ 40% 20% 10% .0% 0.1 duty cycle = t1/t2 Read time at end of t1, $\left(\frac{Z_{\theta JC}}{R_{\theta JC}}\right) \cdot R_{\theta JC \, (max)}$ $\mathbf{T_{J\,(max)}} - \mathbf{T_{C}} = \mathbf{P_{D\,(peak)}}$ 10-4 10-3 10-2 10-1 10<sup>1</sup> $10^2$ t1 - Power Pulse Duration - s

Figure 7.

#### MAXIMUM POWER DISSIPATION JUNCTION TO AMBIENT



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#### THERMAL INFORMATION

# MAXIMUM POWER DISSIPATION JUNCTION TO CASE vs

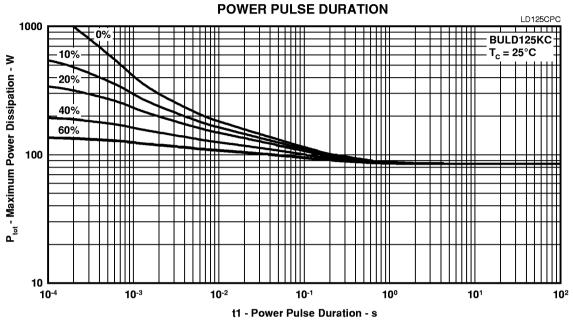


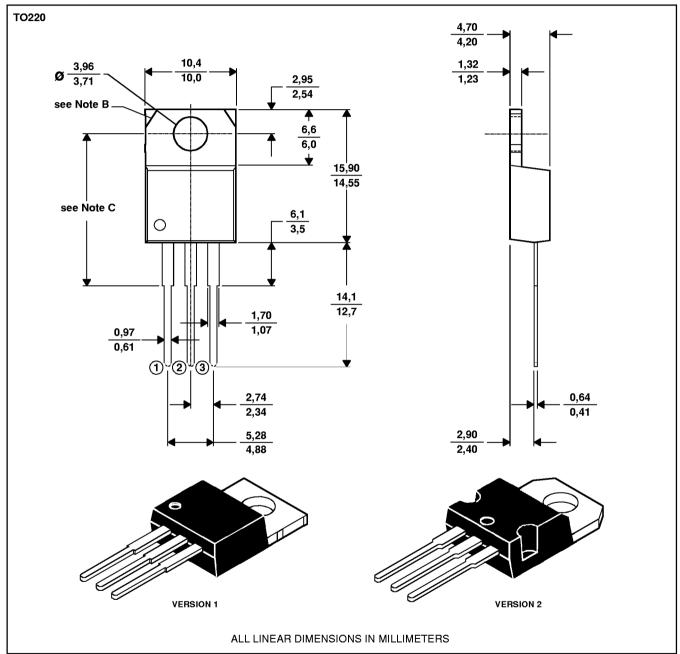
Figure 9.

#### **MECHANICAL DATA**

#### TO-220

#### 3-pin plastic flange-mount package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



NOTES: A. The centre pin is in electrical contact with the mounting tab.

B. Mounting tab corner profile according to package version.
C. Typical fixing hole centre stand off height according to package version.
Version 1, 18.0 mm. Version 2, 17.6 mm.

MDXXBE



# BULD125KC NPN SILICON TRANSISTOR WITH INTEGRATED DIODE

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